Notice of References Cited Application/Control No. 10/632,082 Examiner Jason M. Han Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

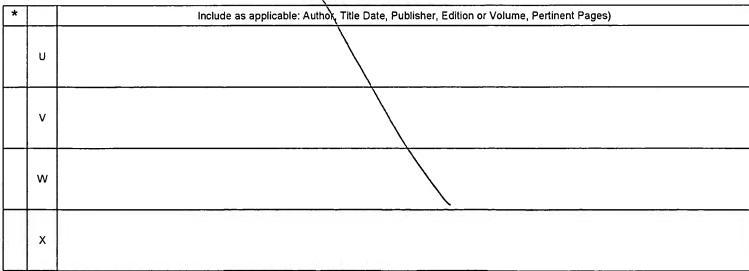
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*	Α	US-7,057,678	06-2006	Ishida et al.	349/58
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